

SW Test Workshop

Semiconductor Wafer Test Workshop

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Introduction of efficient design tools for vertical probe and innovative probe material, Rhodeo6



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1. Abstract

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1.1. Efficient design tool for vertical probe

Inconveniences of conventional finite element method:

- 1) Much time and efforts required in data making.
- 2) Difficult to understand intuitively physical meaning of design parameters.

New design tools based on mechanics of material have following merits:

- (1) Easy and speedy design.
- (2) Increased physical understanding to design parameters

1.2. Innovative probe material, Rhodeo6

Features of Rhodeo6

- (1) Made of Rhodium more than 99.8 %.
- (2) Small electrical resistance
- (3) High elasticity
- (4) High hardness.
- (5) Low contact resistance
- (6) Long probe life

Hopeful Application fields for Rhodeo6

(1) Power Semiconductor

(2) Narrow Pitch Device

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2. Efficient design tools for vertical probe

Two design tools have been developed based on mechanical models:

- (1) Buckling Beam Design Tool
- (2) Cobra Design Tool

Required time for calculation will be:

- * For one case < one minute
- * For try and error to decide parameters < fifteen minutes

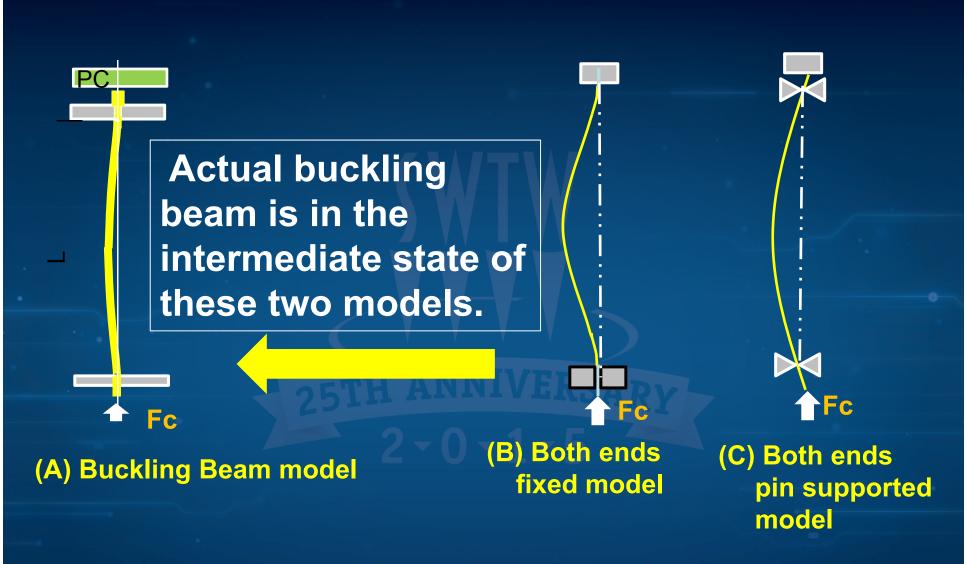


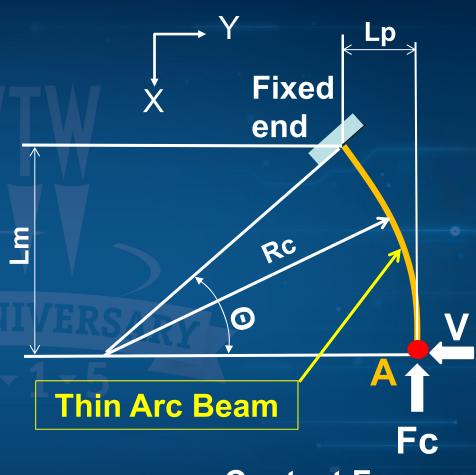
Figure 2-1 Buckling Beam Simulation Model

For cobra analysis, it is very useful to use

the theory of "transformation of thin arc beam"

developed by Kanazawa University in Japan *1).

*1) Reference URL: http://ads.w3.kanazawau.ac.jp/hojo/zairiki/text/05energy/energy03.htm



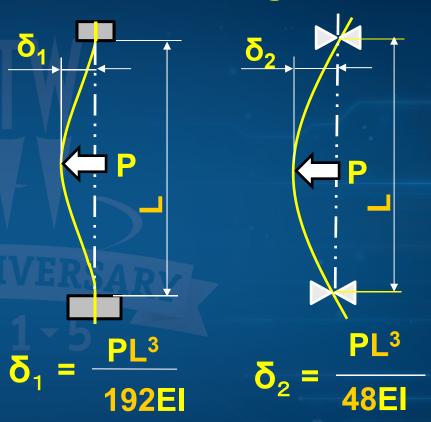
Contact Force

Figure 2-2 Cobra Simulation Model

2.2. Development of Buckling Beam Design Tool

2.2.1. The way to express actual buckling beam

Compare the compliance caused by outer force P.



- (B) Both ends fixed model
 - (C) Both ends supported model

Figure 2-3 Comparison of compliance in two models

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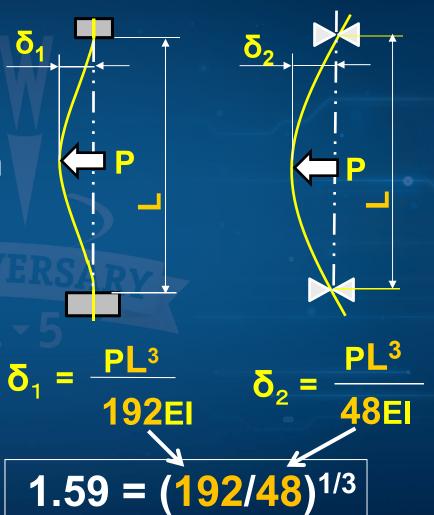
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$$L \Rightarrow a \cdot L$$

a: correction coefficient

$$a = 1 \sim 1.59$$

in case of starting from both ends fixed model.



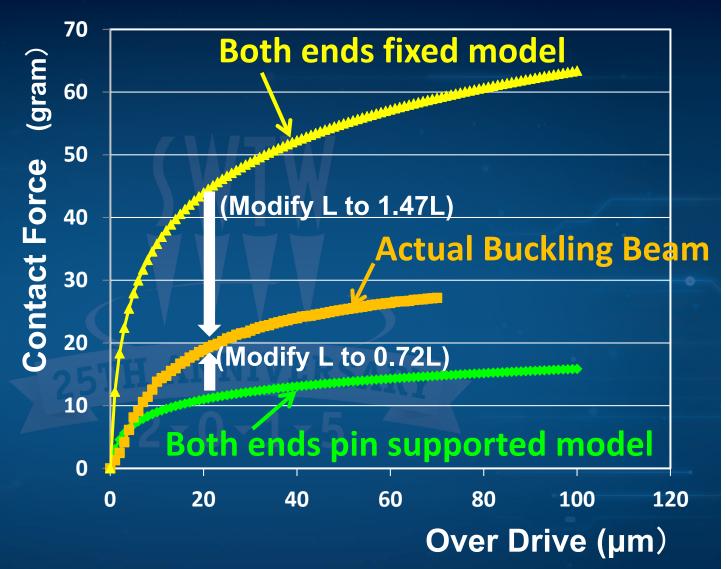


Figure 2-4 Curve of Contact Force versus Over Drive of different models compared with the actual measured values

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Diameter

= 5.4 mm

= 229 GPa

= 2.5 mil = 63 µm

Elasticity modulus

Beam length L

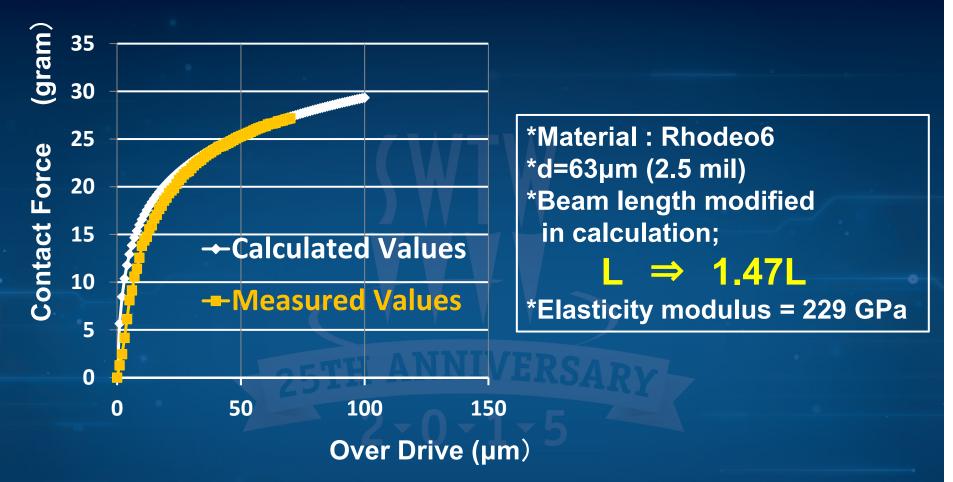


Figure 2-5 Curve of Contact Force versus Over Drive

---- Comparison of calculated data by design tool and experimentally measured data

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2.2.2. Model analysis for buckling beam

To get Performance Chart (curve of contact force versus over drive), following analysis is required:

Center Deviation e as function of Total Over Drive TOD

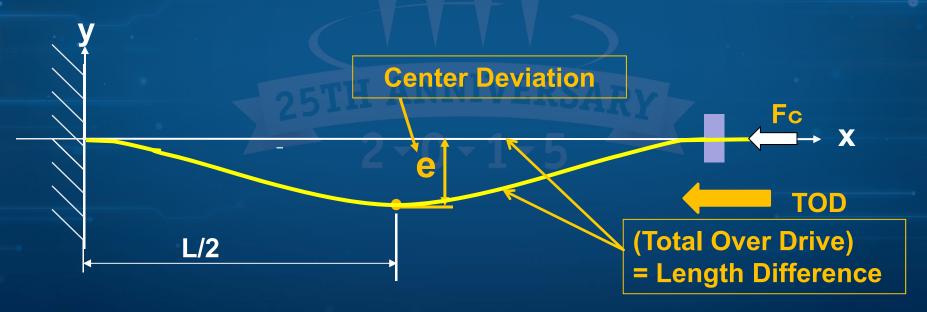


Figure 2-6-1 Buckling beam Model of Both Ends Fixed

To get Performance Chart numerically, following analysis is required:

2) Local Spring Constant K(e) as function of e.

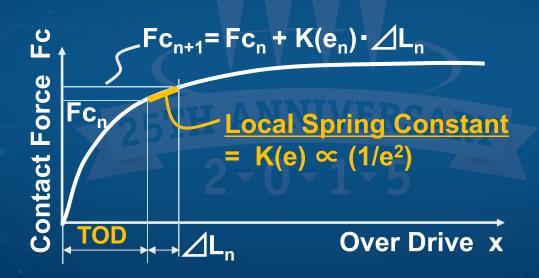


Figure 2-7-1 Numerical method to get performance chart

[Method to get e as function of Total Over Drive TOD]

TOD(e) = 2-(OA-L/2) =
$$2\int_{0}^{L/2} \left\{ \sqrt{1 + (dY/dx)^2} - 1 \right\} dx - (2-1)$$

$$Y(x) = -(e/2)\{1-\cos(2\pi x/L)\}$$
 *2) --- (2-2)

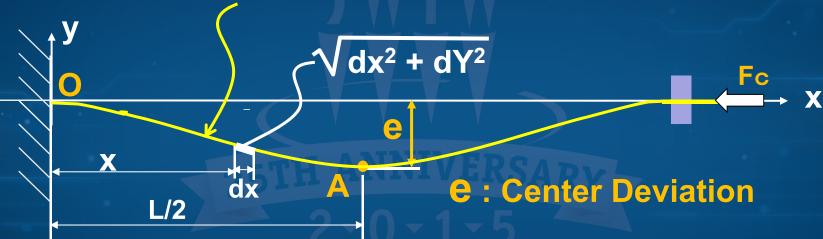


Figure 2-6-2 Buckling beam Model of Both Ends Fixed

Center Deviation
$$e = (2/\pi) \sqrt{L-TOD}$$
 ----- (2-3)

*2) Reference URL: http://kentiku-kouzou.jp/struc-oirazakuturyoutan.html

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[Method to get Local Spring Constant K(e)]

By analyzing quarter model of Figure 2-8, **Spring Constant K(e) is given.**

$$K(e) = (\angle Fc/\angle L) = (8EI)/(Le^2)$$
 ---- (2-4)

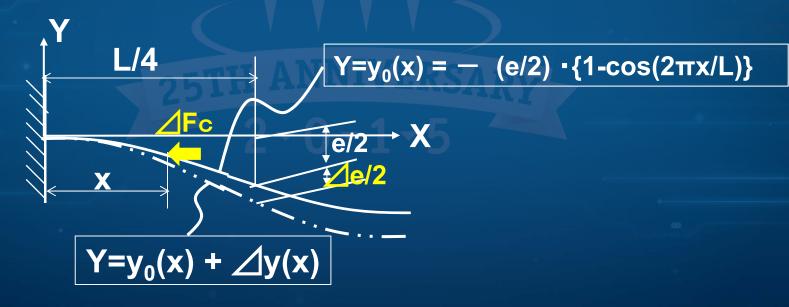


Figure 2-8 **Quarter Model**

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2.2.3. Numerical Method to get Performance Chart

Over Drive axis is divided into each section,

$$\triangle L_1, \triangle L_2, \dots, \triangle L_n$$

Total Over Drive

TOD(n) =
$$\sum_{i=1}^{n-1} \triangle L_i$$
 ---- (2-5)

Center Deviation

$$e_n = (2/\pi) / \sqrt{L - TOD(n)} - (2-6)$$

Local spring constant

$$K(e_n) = (8EI)/(Le_n^2)$$
 ---- (2-7)

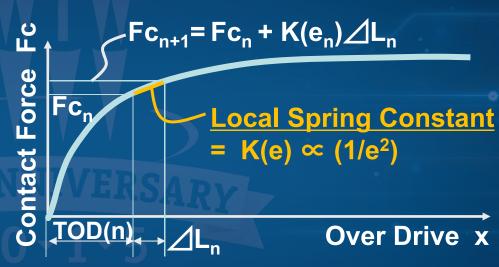


Figure 2-7-2 Numerical method to get performance chart

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Contact Force
$$Fc_n = \sum_{i=1}^{n-1} K(e_i) \angle L_i$$
 ---- (2-8)

3. Innovative probe material, Rhodeo6 3.1. Comparison of physical properties

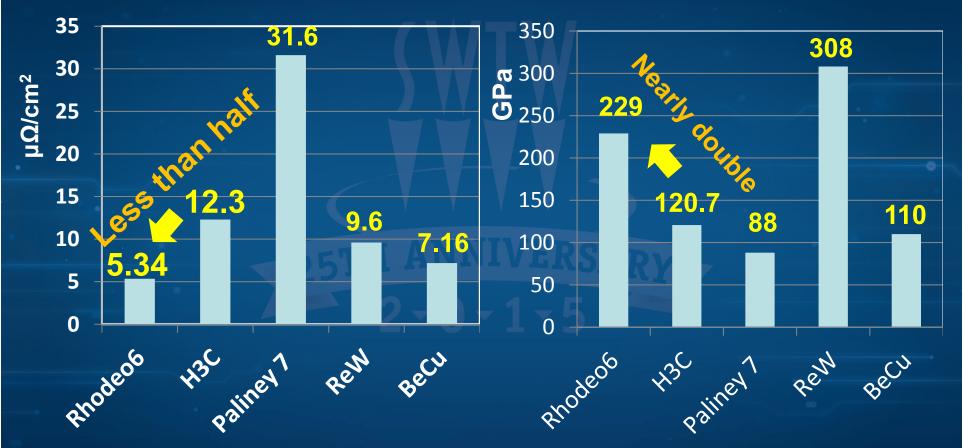
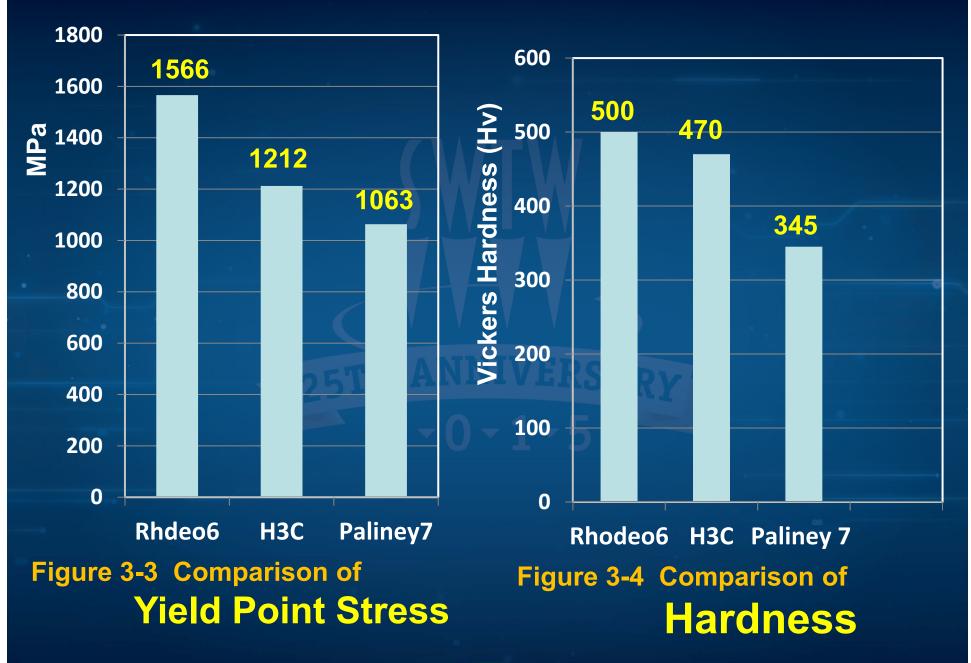


Figure 3-1 Comparison of Electrical Resistance

Figure 3-2 Comparison of Elasticity



3.2. Features of Rhodeo6

- (1) Small electrical resistance ⇒ High CCC
- (2) High elasticity
- (3) High hardness
- (4) Low contact resistance
- (5) Long probe life

Chemical and Physical Stability

No Compound with other substance No Oxidization Film is formed.

3.3. Technical Difficulties to get thin wire

- (a) Stiffness increases during wire drawing.
- (b) Misalignment or excessive drawing force could cause wire cut.

In drawing Rhodeo6, careful attentions required.

- Precise Alignment
- Timely Annealing or Drawing during heat

3.4. Development progress of Rhodedo6 at present

- 2 mil (50 μ) straight wire is available.
- Sample vertical probes of 2 mil are to be manufactured and delivered.
 (Made in USA)
- Trial manufacturing of 35 μ wire is in progress.
 (Final goal : 25 μ)

3.5. Hopeful application fields

(1)Power Semiconductor

- High Current
- High Temperature

(2) Narrow Pitch Device

With Thin Probe

- Certain Contact required
- Signal Reliability required

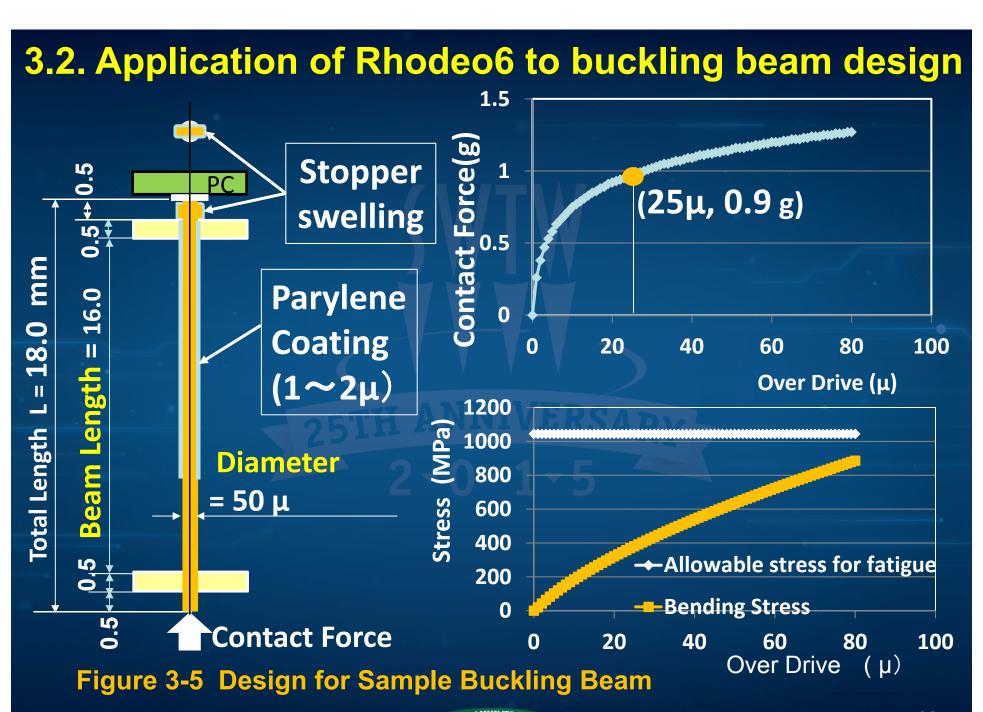
Features of Rhodeo6

High CCC

Chemically **Physically Stable**

High **Elasticity Hardness**

Low Resistance



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3.3. Application of Rhodeo6 to cobra design

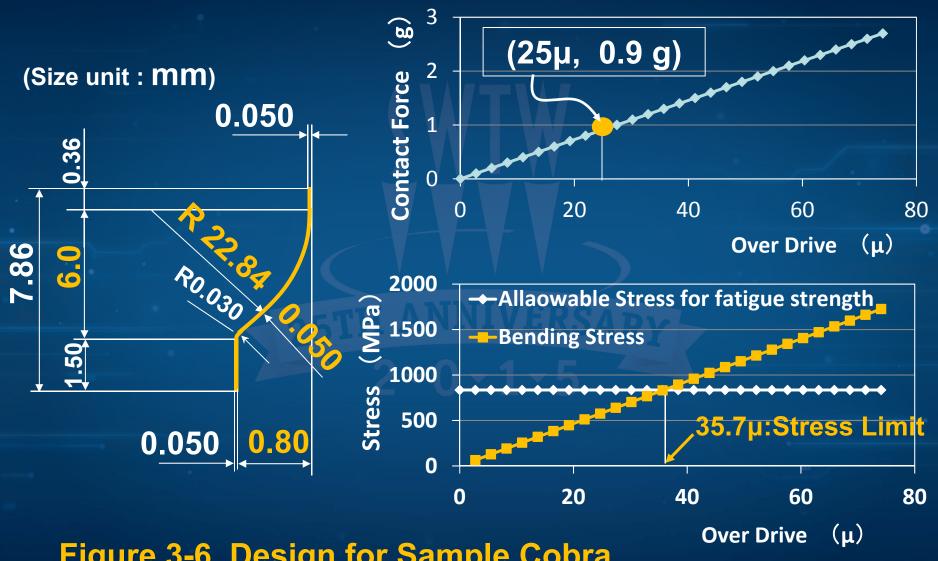


Figure 3-6 Design for Sample Cobra

4. Summary

 New design tools for vertical probe based on mechanics of material have brought following merits:

(1) Easy and Handy:

- Input data = diameter, length and distance, etc.
- PC is available.

(2) Speedy

- one case < one minute, total < fifteen minutes
- (3) Improved physical understanding to parameters

- New probe material, Rhodeo6 has following features:
 - (1) Small electrical resistance ⇒ High CCC
 - (2) High elasticity
 - (3) High hardness
 - (4) Low contact resistance
 - (5) Long probe life
- Trial vertical probe design showed performance below:
 - * Contact Force 0.9 g at Over Drive 25 μ
- Hopeful application fields for Rhodeo6 will be :
 - 1) Power Semiconductor
 - 2) Narrow Pitch Device